### CHANGE NOTIFICATION



Analog Devices, Inc. 1630 McCarthy Blvd., Milpitas CA (408) 432-1900

March 06, 2018 PCN\_030618

Dear Sir/Madam:

## Subject: Notification of Change to LTC4360-1, LTC4360-2 Datasheet

Please be advised that Analog Devices, Inc. Milpitas, California has made a minor change to the LTC4360-1, LTC4360-2 product datasheet to facilitate improvement in our manufacturing capability. The changes are shown on the attached page of the marked up datasheet. There was no change in form, fit, function, quality or reliability of the product. The product shipped after May 06, 2018 will be tested to the new limits.

Should you have any questions or concerns please contact your local Analog Devices sales representatives or you may contact me at 408-432-1900 ext. 2077, or by e-mail at <a href="mailto:jason.hu@analog.com"><u>JASON.HU@ANALOG.COM</u></a>. If I do not hear from you by May 06, 2018, we will consider this change to be approved by your company.

Sincerely,

Jason Hu Quality Assurance Engineer

For questions on this PCN, please contact Jason Hu or you may send an email to your regional contacts below or contact your local ADI sales representatives.

Rest of Asia: PCN ROA@analog.com

#### new parameter

# LTC4360-1/LTC4360-2

# **ELECTRICAL CHARACTERISTICS** The ullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^{\circ}C$ . $V_{IN} = 5V$ , $V_{\overline{ON}} = 0V$ (LTC4360-1) unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
Supplies							
VIN	Input Voltage Range		•	2.5		80	V
V <sub>IN(UVL)</sub>	Input Undervoltage Lockout	V <sub>IN</sub> Rising	•	1.8	2.1	2.45	V
I <sub>IN</sub>	Input Supply Current	LTC4360-1 Von = 0V, LTC4360-2	•		220	400	μА
		LTC4360-1 V <sub>ON</sub> = 2.5V	•		1.5	10	μА
Thresholds							
V <sub>IN(OV)</sub>	IN Pin Overvoltage Threshold	V <sub>IN</sub> Rising	•	5.684	5.8	5.916	V
V <sub>IN(OVL)</sub>	IN Pin Overvoltage Recovery Threshold	V <sub>IN</sub> Falling	•	5.51	5.7	5.85	V
ΔV <sub>OV</sub>	Overvoltage Hysteresis		•	25	100	<del>200</del> —	mV
External Gate	Drive					300	
ΔV <sub>GATE</sub>	External N-Channel MOSFET Gate Drive (V <sub>GATE</sub> – V <sub>OUT</sub> )	$2.5V \le V_{IN} < 3V$ , $I_{GATE} = -1\mu A$ $3V \le V_{IN} < 5.5V$ , $I_{GATE} = -1\mu A$	•	3.5 4.5	4.5 6	6 7.9	V
V <sub>GATE</sub> (TH)	GATE High Threshold for PWRGD Status	V <sub>IN</sub> = 3.3V V <sub>IN</sub> = 5V	•	5.7 6.7	6.3 7.2	6.8 7.8	V
I <sub>GATE(UP)</sub>	GATE Pull-Up Current	V <sub>GATE</sub> = 1V	•	-5	-10	-15	μА
V <sub>GATE(UP)</sub>	GATE Ramp-Up	V <sub>GATE</sub> = 1V to 7V	•	1.5	3	4.5	V/ms
IGATE(FST)	GATE Fast Pull-Down Current	Fast Turn-Off, VIN = 6V, VGATE = 9V	•	15	30	60	mA
IGATE(DN)	GATE Pull-Down Current	Von = 2.5V, VGATE = 9V (LTC4360-1)	•	10	40	80	μА
Input Pins	•						
I <sub>OUT(IN)</sub>	OUT Input Current	V <sub>OUT</sub> = 5V, V <sub>ON</sub> = 0V V <sub>OUT</sub> = 5V, V <sub>ON</sub> = 2.5V	•	5	10 0	20 ±3	μA μA
V <sub>ON(TH)</sub>	ON Input Threshold	(LTC4360-1)	•	0.4		1.5	V
ION	ON Pull-Down Current	Von = 2.5V (LTC4360-1)	•	2.5	5	10	μА
Output Pins	·						
V <sub>GATEP(CLP)</sub>	IN to GATEP Clamp Voltage	V <sub>IN</sub> = 8V to 80V (LTC4360-2)	•	5	5.8	7.5	V
R <sub>GATEP</sub>	GATEP Resistive Pull-down	V <sub>GATEP</sub> = 3V (LTC4360-2)	•	0.8	2	3.2	MΩ
V <sub>PWRGD(OL)</sub>	PWRGD Output Low Voltage	V <sub>IN</sub> = 5V, I <sub>PWRGD</sub> = 3mA	•		0.23	0.4	V
Rpwrgd	PWRGD Pull-Up Resistance to OUT	$V_{IN} = 6.5V$ , $V_{\overline{PWRGD}} = 1V$	•	250	500	800	kΩ
Delay							
ton	GATE On Delay	V <sub>IN</sub> High to I <sub>GATE</sub> = -5μA	•	50	130	200	ms
toff	GATE Off Propagation Delay	V <sub>IN</sub> = Step 5V to 6.5V to PWRGD High	•		0.25	1	μs
tpwrgd	PWRGD Delay	V <sub>IN</sub> = Step 5V to 6.5V V <sub>GATE</sub> > V <sub>GATE</sub> (TH) to PWRGD Low	•	25	0.25 65	1 100	μs ms
ton(off)	ON High to GATE Off	Von = Step 0V to 2.5V (LTC4360-1)	•		2	5	μs
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Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to GND unless otherwise specified.

 $\label{eq:Note 3: An internal clamp limits $V_{GATE}$ to a minimum of 4.5V above $V_{OUT}$. Driving this pin to voltages beyond this clamp may damage the device.}$ 

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3